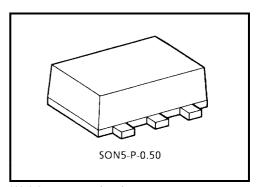
TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC7SZ126AFE

Dual Bus Buffer 3-State Output

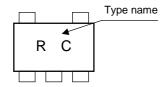
Features

- High output drive: ±24 mA (min) @VCC = 3 V
- Super high speed operation: t_{pd} 2.6 ns (typ.) @VCC = 5 V, 50 pF
- Operation voltage range: $V_{CC \text{ (opr)}} = 1.8 \sim 5.5 \text{ V}$
- Latch-up performance: ±500 mA or more
- ESD performance: ±200 V or more (JEITA) ±2000 V or more (MIL)
- Power down protection is provided on all inputs and outputs.
- \bullet Matches the performance of TC74LCX series when operated at 3.3 V VCC.

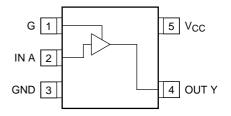


Weight: 0.003 g (typ.)

Marking



Pin Assignment (top view)



Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit
Power supply voltage	V _{CC}	-0.5~6	V
DC input voltage	V _{IN}	-0.5~6	V
DC output voltage	V _{OUT}	-0.5~V _{CC} + 0.5	V
Input diode current	I _{IK}	-20	mA
Output diode current	lok	±20	mA
DC output current	lout	±50	mA
DC V _{CC} /ground current	Icc	±50	mA
Power dissipation	PD	150	mW
Storage temperature	T _{stg}	-65~150	°C
Lead temperature (10s)	TL	260	°C

Truth Table

А	G	Υ
Х	L	Z
L	Н	L
Н	Н	Н

Logic Diagram



Recommended Operating Conditions

Characteristics	Symbol	Rating	Unit
Supply voltage	Vcc	1.8~5.5	V
Supply voltage	vCC	1.5~5.5 (Note)	V
Input voltage	V _{IN}	0~5.5	V
Output voltage	V _{OUT}	0~V _{CC}	V
Operating temperature	T _{opr}	-40~85	°C
		$0 \sim 20 \; (V_{CC} = 1.8 \; V, \; 2.5 \; V \pm 0.2 \; V)$	
Input rise and fall time	dt/dv	0~10 (V _{CC} = 3.3 V \pm 0.3 V)	ns/V
		$0~5~(V_{CC} = 5.5~V \pm 0.5~V)$	

Note: Data retention only

2

Electrical Characteristics

DC Characteristics

Characteristics S		Symbol	Symbol Test Condition			Ta = 25°C			Ta = -40~85°C		Unit
		Symbol			V _{CC} (V)	Min	Тур.	Max	Min	Max	Unit
High level	.,	_		1.8	0.75 × V _{CC}		_	0.75 × V _{CC}	_	. V	
	V _{IH}			2.3~5.5	0.7 × V _{CC}	_	_	0.7 × V _{CC}	_		
Input voltage				1.8	—		0.25 × V _{CC}	_	0.25 × V _{CC}		
	Low level	V _{IL}	_		2.3~5.5	_	_	0.3 × V _{CC}	_	0.3 × V _{CC}	
					1.8	1.7	1.8	_	1.7	_	
				I _{OH} = -100 μA	2.3	2.2	2.3	_	2.2	_	
				ΙΟΗ = – 100 μΑ	3.0	2.9	3.0	_	2.9	_	
	High level	V _{ОН}	V _{IN} = V _{IH} or V _{IL}		4.5	4.4	4.5	_	4.4	_	
	riigirievei			$I_{OH} = -8 \text{ mA}$	2.3	1.9	2.15	_	1.9	_	V
				$I_{OH} = -16 \text{ mA}$	3.0	2.4	2.8	_	2.4	_	
Outside a library				I _{OH} = -24 mA	3.0	2.3	2.68	_	2.3	_	
				$I_{OH} = -32 \text{ mA}$	4.5	3.8	4.2	_	3.8	_	
Output voltage			V _{IN} = V _{IH}	I _{OL} = 100 μA	1.8	_	0	0.1	_	0.1	
					2.3	_	0	0.1	_	0.1	
					3.0	_	0	0.1		0.1	
	Low level	V _{OL}			4.5	_	0	0.1	_	0.1	
	LOW level			$I_{OL} = 8 \text{ mA}$	2.3	_	0.1	0.3	_	0.3	
				$I_{OL} = 16 \text{ mA}$	3.0	_	0.15	0.4	_	0.4	
				$I_{OL} = 24 \text{ mA}$	3.0	_	0.22	0.55	_	0.55	
				I _{OL} = 32 mA	4.5	_	0.22	0.55	_	0.55	
Input leakage curre	nt	I _{IN} V _{IN} = 5.5 V or GND		0~5.5	—		±1	—	±10	μΑ	
3-state output off-st	ate output off-state current I_{OZ} $V_{IN} = V_{IH}$ or V_{IL} , $V_{OUT} = 0 \sim 5.5 \text{ V}$		1.8~5.5	_		±1	_	±10	μА		
Power off leakage	current	I _{OFF} V _{IN} or V _{OUT} = 5.5 V		_T = 5.5 V	0.0			1	_	10	μΑ
Quiescent supply c	urrent	I _{CC} V _{IN} = 5.5 V or GND		5.5	_		2	_	20	μΑ	

3

AC Characteristics (unless otherwise specified, Input: $t_r = t_f = 3$ ns)

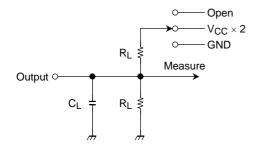
Characteristics	Symbol	Test Condition		Ta = 25°C		Ta = -40~85°C		Unit	
Onaraciensiles Syntk		rest Condition	V _{CC} (V)	Min	Тур.	Max	Min	Max	Offic
		C_L = 15 pF, R_L = 1 $M\Omega$	1.8	2.0	5.3	11.0	2.0	11.5	
			2.5 ± 0.2	0.8	3.4	7.5	0.8	8.0	
Propagation delay time	t _{pLH}		3.3 ± 0.3	0.5	2.5	5.2	0.5	5.5	
Fropagation delay time	t _{pHL}		5.0 ± 0.5	0.5	2.1	4.5	0.5	4.8	
		C 50 x F B 500 O	3.3 ± 0.3	1.5	3.2	5.7	1.5	6.0	
	$C_L = 50 \text{ pF}, R_L = 500 \Omega$	5.0 ± 0.5	0.8	2.6	5.0	0.8	5.3		
	^t pZH ^t pZL	C_L = 50 pF, R_L = 500 Ω	1.8	2.0	6.5	11.5	2.0	12.0	ns
Output enable time			2.5 ± 0.2	1.5	3.8	8.0	1.5	8.5	113
			3.3 ± 0.3	1.5	3.2	5.7	1.5	6.0	
			5.0 ± 0.5	0.8	2.3	5.0	0.8	5.3	
Output disable time		$C_L = 50 \text{ pF}, R_L = 500 \Omega$	1.8	2.0	5.6	11.0	2.0	12.0	
	t _{pLZ}		2.5 ± 0.2	1.0	4.0	8.0	1.5	8.5	
	t _{pHZ}	OL = 30 pr , RL = 300 12	3.3 ± 0.3	1.0	3.5	5.7	1.0	6.0	
			5.0 ± 0.5	0.5	2.7	4.7	0.5	5.0	
Input capacitance	C _{IN}		0~5.5	_	4	_	_	_	pF
Power dissipation	C _{PD}	(Note)	3.3		20			_	pF
capacitance	OPD	(Note)	5.5	_	27	_	_	_	

Note: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$

AC Characteristics Measurement Circuit

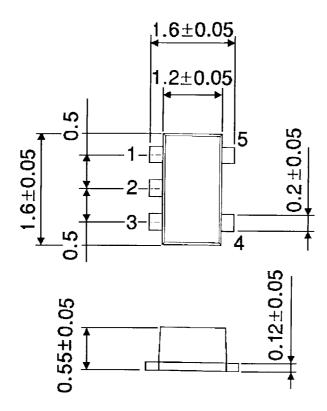


Characteristics	Switch
t _{pLH} , t _{pHL}	Open
t _{pLZ} , t _{pZL}	$V_{CC}\times 2$
t _{pHZ} , t _{pZH}	GND

4 2002-01-16

Package Dimensions

SON5-P-0.50 Unit: mm



Weight: 0.003 g (typ.)

5

RESTRICTIONS ON PRODUCT USE

000707EBA

- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.
 In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc..
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in this document shall be made at the customer's own risk.
- The products described in this document are subject to the foreign exchange and foreign trade laws.
- The information contained herein is presented only as a guide for the applications of our products. No
 responsibility is assumed by TOSHIBA CORPORATION for any infringements of intellectual property or other
 rights of the third parties which may result from its use. No license is granted by implication or otherwise under
 any intellectual property or other rights of TOSHIBA CORPORATION or others.
- The information contained herein is subject to change without notice.